

BRITISH STANDARDS INSTITUTION

2 PARK STREET, LONDON. W1A 2BS

Specification available from:- AS SHOWN IN PD 9002
AND CECC 00 200 AND

BS CECC 90102 - 027

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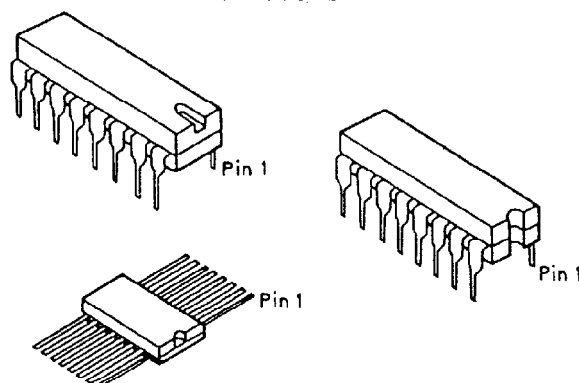
ELECTRONIC COMPONENTS OF ASSESSED QUALITY
DETAIL SPECIFICATION IN ACCORDANCE WITH:

BS CECC 90 000 : 1976
BS CECC 90 100 : 1977

MANUFACTURERS TYPE NUMBER

54S158
64S158
74S158
84S158

Outline not to scale: Isometric projection
Marking information see clause 1



Refer to IEC 191-1-50a (type A50C)
Dual-in-Line (plastic or ceramic)
refer to Appendix A1.3
Flatpack (metal or ceramic)

SEE PD 9002 AND CECC 00 200
For ordering information see
clause 1

QUADRUPLER 2-LINE-TO-1-LINE
DATA SELECTOR/MULTIPLEXERS

TYPICAL CONSTRUCTION
SILICON MONOLITHIC BIPOLAR
CAVITY AND NON-CAVITY
PACKAGES

ASSESSMENT LEVELS
R, S, T, AND V

1. Type description

1.1 Truth table

INPUTS				OUTPUT
STROBE	SELECT	A	B	
H	X	X	X	H
L	L	L	X	H
L	L	H	X	L
L	H	X	L	H
L	H	X	H	L

H = High level

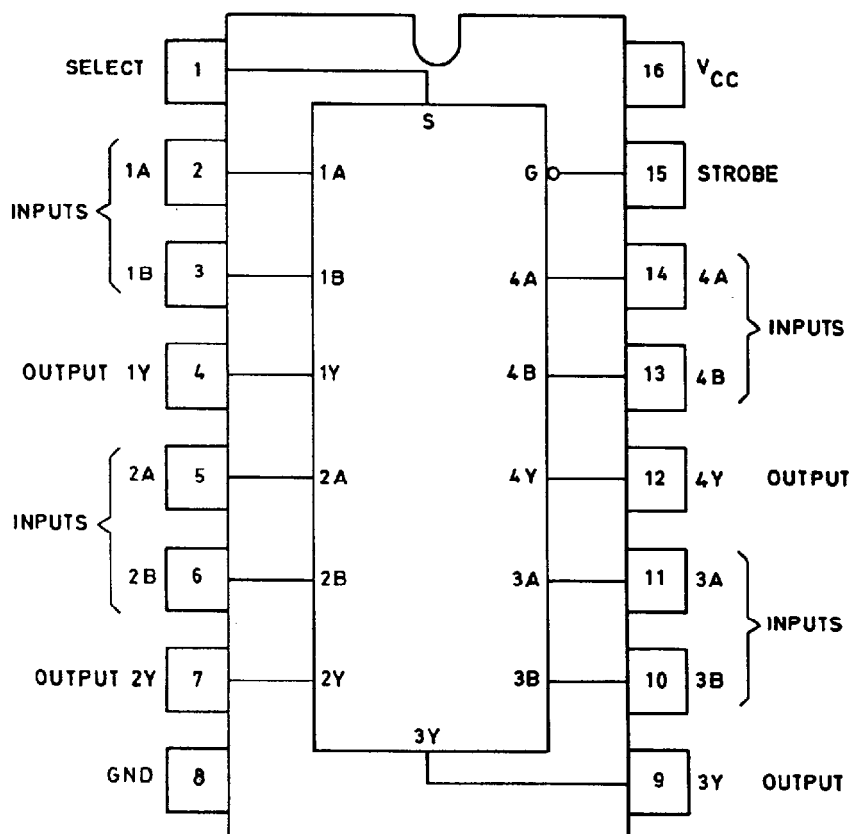
L = Low level

X = Logic level irrelevant

Refer to Qualified Products List PD 9002 and/or CECC 00 200
for details of manufacturers approved to this specification

1.2 Terminal identification, type designation and marking

1.2.1 Terminal identification



Quadruple 2-line to 1-line data selector/multiplexers

1.2.2 Type designation

TEMPERATURE RANGE	PACKAGE		
	Ceramic Dual-in-Line	Plastic Dual-in-Line	Ceramic Flatpack
0 + 70	74S158J	N	W
-25 + 85	84S158J		
-40 + 85	64S158J		
-55 +125	54S158J		

1.2.3 Marking

Each integrated circuit shall bear the following markings:

- (1) Terminal identification
- (2) Type designation
- (3) Date code
- (4) Factory identification code (unless derived from trademark)
- (5) Manufacturers trade name or mark
- (6) Mark of conformity (unless a certificate of conformity is used)

1.3 Ordering information

Orders for these integrated circuits shall contain the following minimum information:

Manufacturers integrated circuit type designation, screening procedures and assessment levels as detailed to this CECC specification number.

(For details of screening procedures see Appendix A1.1).

2. Limiting conditions of use (not for inspection purposes)

2.1	Minimum and maximum continuous supply voltage	V_{CC}						-0,5V +7,0V
2.2	Minimum and maximum input voltages							
2.2.1	Minimum and maximum input voltage	V_I						-0,5V +5,5V
2.2.2	Maximum input voltage between multiple emitter transistor inputs	V_{II}						+5,5V
				54S	64S	74S	84S	
2.3	Minimum and maximum operating ambient temperatures	$T_{amb}(^{\circ}C)$	min.	-55	-40	0	-25	
			max.	+125	+85	+70	+85	
2.4	Minimum and maximum storage temperatures	$T_{stg}(^{\circ}C)$	min.	-65	(All types)			
			max.	+150				

3. Recommended operating conditions and associated characteristics (not for inspection purposes)

3.1 Recommended operating conditions.

These apply over the operating ambient temperature range unless otherwise stated.

3.1 (contd)

Description	Symbol	Type	Value	Unit
Positive supply voltage range	V_{CC}	54S 64/74/84S	4,5 - 5,5 4,75 - 5,25	V V
Minimum value of High level input voltage	V_{IHB}	All types	2,0	V
Maximum value of High level input voltage	V_{IHA}	All types	5,5	V
Minimum value of Low level input voltage	V_{ILB}	All types	0	V
Maximum value of Low level input voltage	V_{ILA}	All types	0,8	V
Maximum value of Low level output current for each output	I_{OLA}	All types	20,0	mA
Maximum value of output current for each output at V_{OH}	$-I_{OHA}$	All types	1,0	mA
D.C. noise margin				
at Low level ($V_{ILA} - V_{OLA}$)	V_{NL}	All types	0,3	V
at High level ($V_{OHB} - V_{IHB}$)	V_{NH}	54S 64/74/84S	0,5 0,7	V V

3.2 Associated characteristics

3.2.1 Minimum and maximum values are given for the worst case operation over the ambient temperature range, except for those conditions marked with an asterisk (*)

	54S	64S	74S	84S	
T _{amb} min.	-55	-40	0	-25	°C
T _{amb} max.	+125	+85	+70	+85	
V _{CC} min.	4,5	4,75			V
V _{CC} max.	5,5	5,25			

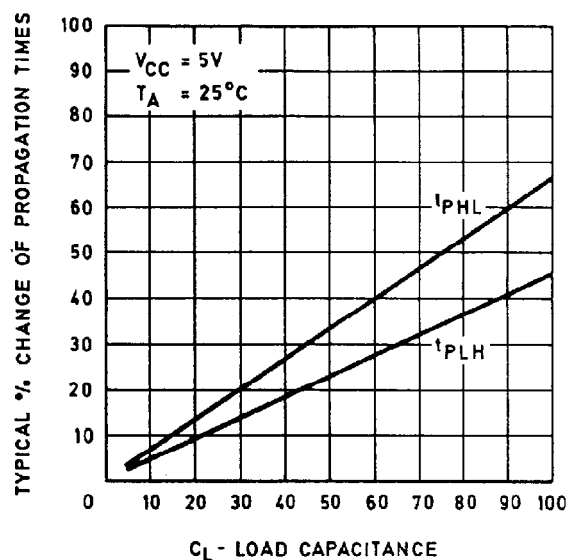
Characteristics	Conditions	$V_{CC}(V)$	Symbol	Min.	Max.	Unit
Total supply current per package	$V_{IN} = 4,5V$ to All inputs Outputs open	V_{CC} max.	I_{CC}	-	61,0	mA
High level input current Select or Strobe input A or B input	$V_{IH(1)} = 5,5V$ $V_{IH(2)} = 2,7V$	V_{CC} max.	$I_{IH(1)}$	-	1,0	mA
		V_{CC} max.	$I_{IH(2)}$	-	100,0	μA
			$I_{IH(2)}$	-	50,0	μA
Low level input current Select or Strobe input A or B input	$V_{IN} = 0,5V$	V_{CC} max.	$-I_{IL}$	-	4,0	mA
			$-I_{IL}$	-	2,0	mA
Input clamping voltage	$-I_{IC} = 18,0mA$	V_{CC} min.	$-V_{IC}$	-	1,2	V
Output voltage 54S 64/74/84S All types	$I_{OUT} = 1,0mA$ $I_{OUT} = 1,0mA$ $I_{OUT} = 20,0mA^{(1)}$	V_{CC} min.	V_{OH}	2,5	-	V
			V_{OH}	2,7	-	V
			V_{OL}	-	0,5	V
Output short circuit current	V_{IN} as required to give High output $V_O = 0V^{(2)}$	V_{CC} max.	$-I_{OS}$	40,0	100,0	mA
Propagation times All types	$T_{amb} = 25^\circ C^*$ test conditions as in Sub-group A5	5,0V				
High to Low level						
From To						
Data Output			t_{PHL}	-	6,0	ns
Strobe Output			t_{PHL}	-	12,0	ns
Select Output			t_{PHL}	-	12,0	ns
Low to High level						
From To						
Data Output			t_{PLH}	-	6,0	ns
Strobe Output			t_{PLH}	-	11,5	ns
Select Output			t_{PLH}	-	12,0	ns

(1) Fan out = 10, (2) Only one output at a time, duration $t \leq 1$ s

*See clauses 3.1 and 3.2.1 of this specification

3.3 Supplementary information

3.3.1 Change of typical propagation time with output loading



3.3.2 Variation of propagation time with temperature

